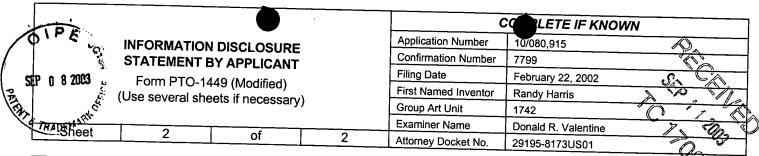
## LETE IF KNOWN NFORMATION DISCLOSURE STATEMENT BY APPLICANT **Application Number** 10/080,915 Confirmation Number 7799 SEP 0 8 2003 Filing Date February 22, 2002 WADEN FUR Form PTO-1449 (Modified) First Named Inventor (Use several sheets if necessary) Randy Harris Group Art Unit 1742 **Examiner Name** Donald R. Valentine Sheet of 2 Attorney Docket No. 29195-8173US01

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\*EXAMINER: Initial if reference considered, whether

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Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application(s).



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considered. Include copy of	of this form with next communication	n to application(s)	w line through citation if not in conformance and not